



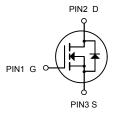
# Product data sheet

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N-Channel MOSFET

Absolute Maximum Ratings (TC=25°C unless otherwise specified)

TO-252

Description

The AOD4144-MS uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

#### **General Features**

V<sub>DS</sub> = 30V I<sub>D</sub> =60 A

 $R_{DS(ON)}$  < 8.5m $\Omega$  @ V<sub>GS</sub>=10V

#### Application

Battery protection

Load switch Uninterruptible power supply

Symbol Parameter		Rating	Units
Vds	Drain-Source Voltage	30	V
Vgs	Gate-Source Voltage	±20	V
I₀@Tc=25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	60	А
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	40	А
I <sub>D</sub> @T <sub>A</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	13.6	А
ID@TA=70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	11.4	Α
Ідм	Pulsed Drain Current <sup>2</sup>	110	А
EAS	Single Pulse Avalanche Energy <sup>3</sup>	57.8	mJ
las	Avalanche Current	34	Α
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>4</sup>	41	W
PD@TA=25°C	Total Power Dissipation <sup>4</sup>	2.42	W
Тѕтс	Storage Temperature Range	-55 to 175	°C
TJ	Operating Junction Temperature Range	-55 to 175	°C
Reja	Thermal Resistance Junction-ambient (Steady State) <sup>1</sup>	62	°C/W
Rejc	Thermal Resistance Junction-Case <sup>1</sup>	3.6	°C/W



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Symbol	Parameter	Parameter Conditions		Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	30			V
∆BVbss/∆TJ	BVDSS Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =1mA		0.027		V/°C
		V <sub>GS</sub> =10V , I <sub>D</sub> =30A		7.5	8.5	
RDS(ON)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =4.5V , I <sub>D</sub> =15A		11	14	mΩ
VGS(th)	Gate Threshold Voltage	V V 1 250 A	1.2	1.5	2.5	V
$\bigtriangleup V_{\text{GS(th)}}$	V <sub>GS(th)</sub> Temperature Coefficient	$-V_{GS}=V_{DS}$ , $I_D=250uA$		-5.8		mV/°0
	Drain-Source Leakage Current	$V_{DS}$ =24V , $V_{GS}$ =0V , $T_{J}$ =25°C			1	uA
IDSS		V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5	
lgss	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =30A		38		S
Rg	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		2.2	3.5	
Qg	Total Gate Charge (4.5V)			12.6	17.6	
Qgs	Gate-Source Charge	V <sub>DS</sub> =15V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =15A		4.2	5.9	nC
$Q_{gd}$	Gate-Drain Charge			5.1	7.1	
Td(on)	Turn-On Delay Time			4.6	9.2	
Tr	Rise Time			12.2	22	ns
Td(off)	Turn-Off Delay Time	I <sub>D</sub> =15A		26.6	53	
T <sub>f</sub>	Fall Time	_		8	16	
Ciss	Input Capacitance			1317	1843	
Coss	Output Capacitance			163	228	pF
Crss	Reverse Transfer Capacitance			131	183	
ls	Continuous Source Current <sup>1,5</sup>				55	А
Іѕм	Pulsed Source Current <sup>2,5</sup>	$-V_{G}=V_{D}=0V$ , Force Current			110	A
Vsd	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , Is=1A , TJ=25°C			1.2	V
t <sub>rr</sub>	Reverse Recovery Time			9.2		nS
Qrr	Reverse Recovery Charge	I⊧=30A , dl/dt=100A/µs ,		2		nC
Qrr	Reverse Recovery Charge	TJ=25°C		2		nc

#### Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Note :

1 . The data tested by surface mounted on a 1 inch $^2$  FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%

3. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =25V,  $V_{GS}$ =10V, L=0.1mH,  $I_{AS}$ =34A

4.The power dissipation is limited by 175  $^\circ\text{C}$  junction temperature

5.The data is theoretically the same as  $I_{\text{D}}$  and  $I_{\text{DM}}$  , in real applications , should be limited by total power dissipation.





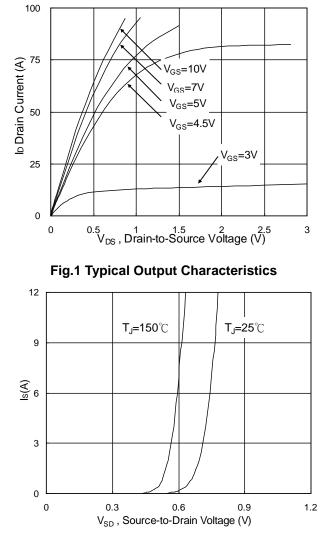


Fig.3 Forward Characteristics of Reverse

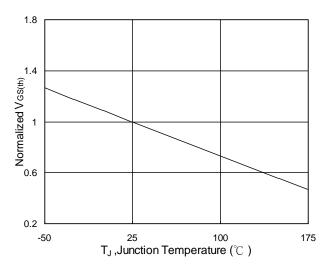


Fig.5 Normalized V<sub>GS(th)</sub> vs. T<sub>J</sub>

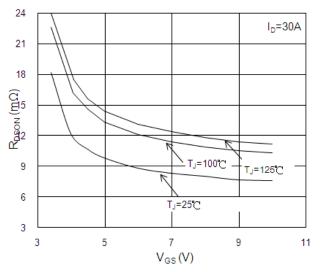


Fig.2 On-Resistance vs. G-S Voltage

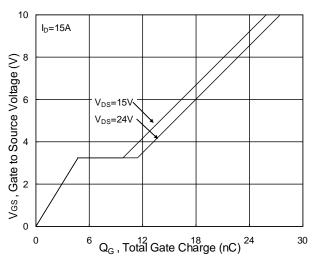


Fig.4 Gate-Charge Characteristics

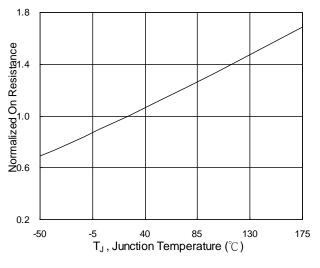
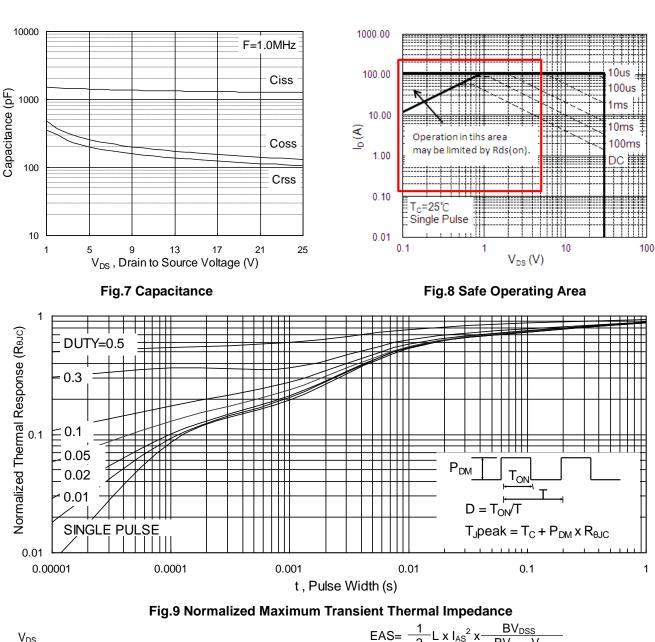


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>





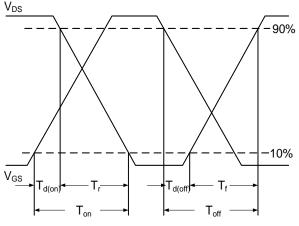
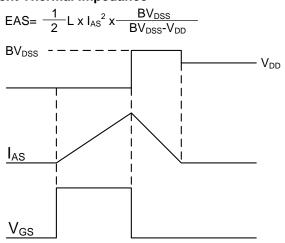


Fig.10 Switching Time Waveform



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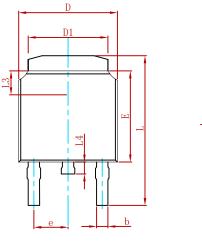
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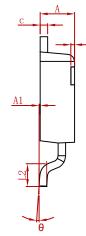
Fig.11 Unclamped Inductive Switching Waveform



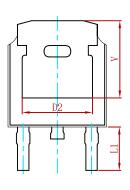


## PACKAGE MECHANICAL DATA



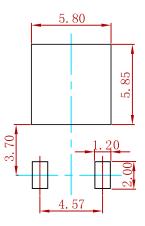


h



Symbol	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.635	0.770	0.025	0.030
С	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830	REF.	0.190 REF.	
E	6.000	6.200	0.236	0.244
е	2.186	2.386	0.086	0.094
L	9.712	10.312	0.382	0.406
L1	2.900	REF.	0.114	REF.
L2	1.400	1.700	0.055	0.067
L3	1.600	REF.	0.063	REF.
L4	0.600	1.000	0.024	0.039
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.250	REF.	0.207	REF.

## Suggested Pad Layout



Note:

1.Controlling dimension:in millimeters.

2.General tolerance:± 0.05mm.

3. The pad layout is for reference purposes only.

### **REEL SPECIFICATION**

P/N	PKG	QTY
AOD4144-MS	TO-252	2500



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